

## Low-Voltage ETR Controller with On-Chip DC-DC Converter

### Overview

The LC72344W and LC72345W are low-voltage electronic tuning microcontrollers that include a DC-DC converter, a PLL that operates up to 230 MHz, a 1/4 duty 1/2 bias LCD driver and other functions on chip. The built-in DC-DC converter provided by these ICs can easily implement a tuning system voltage generator circuit, and furthermore, since the transistor required for the low-pass filter is built in, these ICs can contribute to further end product cost reductions. Additionally, the DC-DC converter output voltage can be provided to other external ICs, making these products optimal for low-voltage portable audio equipment that includes a radio receiver.

#### **Functions**

• Program memory (ROM): 3072 × 16 bits (6 KB)

LC72344W

 $4096 \times 16$  bits (8 KB)

LC72345W

• Data memory (RAM): 192 × 4 bits LC72344W

256 × 4 bits LC72345W

• Cycle time: 40 µs (all 1-word instructions)

• Stack: 8 levels

• LCD driver: 48 to 76 segments (1/4 duty, 1/2 bias drive)

• Interrupts: One external interrupt

Timer interrupts (1, 5, 10, and 50 ms)

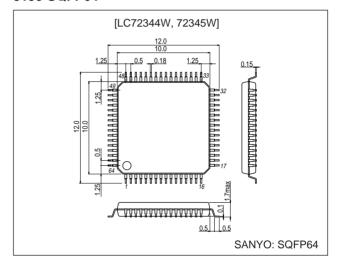
- A/D converter: Two input channels (5-bit successive approximation conversion)
- Input ports: 6 ports (of which 2 can be switched for use as A/D converter inputs)
- Output ports: 6 ports (of which 1 can be switched for use as the beep tone output and 2 are opendrain ports)
- I/O ports: 16 ports (of which 8 can be switched for use as LCD ports as mask options)

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## **Package Dimensions**

unit: mm

#### 3190-SQFP64



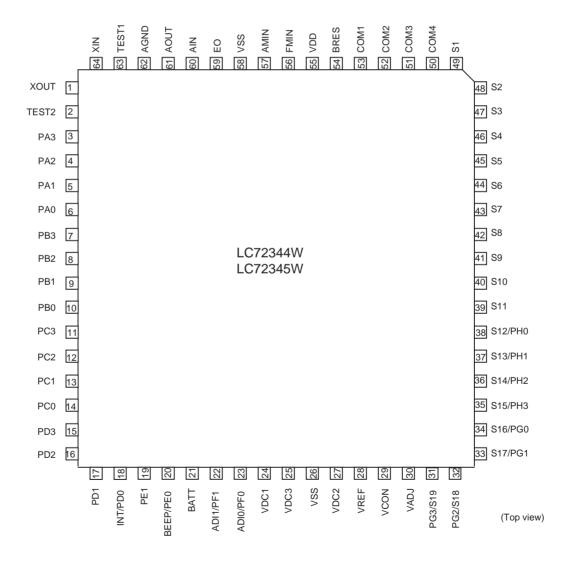
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- PLL: Supports dead band control (two types)
   Reference frequencies: 1, 3, 5, 6.25, 12.5, and 25 kHz
- Input frequencies: FM band: 10 to 230 MHz AM band: 0.5 to 10 MHz
- Input sensitivity: FM band: 35 mV rms (50 mV rms at 130 MHz or higher frequency)
   AM band: 35 mV rms
- External reset input: During CPU and PLL operation, instruction execution is started from location 0.
- Built-in power-on reset circuit:
   The CPU starts executing from location 0 when power is first applied.
- Static power-on function: Backup state clear function using the BATT pin.

- Halt mode: The controller operating clock is stopped.
- Backup mode: The crystal oscillator is stopped.
- Beep tone: 1.5 and 3.1 kHz
- Built-in DC-DC converter: Two systems (One system can be used as an external circuit power supply by providing an external transistor.)
- Built-in low-pass filter amplifier: An external low-pass filter amplifier circuit is no longer required in end products.
- Remaining power check function: The battery voltage can be directly converted to a digital value by the A/D converter.
- Memory retention voltage: 0.9 V or higher.
- V<sub>DD</sub> voltage: 0.9 to 1.8 V
- Package: SQFP-64 (0.5 mm lead pitch)

### **Pin Assignment**



# Specifications Absolute Maximum Ratings at Ta = 25°C, $V_{SS}$ = 0 V

Parameter	Symbol	Conditions	Ratings	Unit
	V <sub>DD</sub> (1)max	VDD	-0.3 to +0.3	V
Maximum aunah waltara	V <sub>DD</sub> (2)max	VDC1	-0.3 to +4.0	V
Maximum supply voltage	V <sub>DD</sub> (3)max	VDC2	-0.3 to +4.0	V
	V <sub>DD</sub> (4)max	VDC3	-0.3 to +4.0	V
Input voltage	V <sub>IN</sub> (1)	PF, FMIN, AMIN, AIN, BATT, and BRES	-0.3 to V <sub>DD</sub> (3) to +0.3	V
input voitage	V <sub>IN</sub> (2)	PA, PC, PD, PG, and PH	-0.3 to V <sub>DD</sub> (1) to +0.3	V
	V <sub>OUT</sub> (1)	AOUT, and PE	-0.3 to +15	V
Output voltage	V <sub>OUT</sub> (2)	PB, PC, PD, PG, and PH	-0.3 to V <sub>DD</sub> (1) +0.3	V
output voltage	V <sub>OUT</sub> (3)	VREF, and EO	-0.3 to V <sub>DD</sub> (3) +0.3	V
	V <sub>OUT</sub> (4)	COM1 to COM4, S1 to S19	-0.3 to V <sub>DD</sub> (4) +0.3	V
	I <sub>OUT</sub> (1)	PC, PD, PG, PH, and EO	0 to 3	mA
	I <sub>OUT</sub> (2)	РВ	0 to 1	mA
Output current	I <sub>OUT</sub> (3)	AOUT, and PE	0 to 2	mA
	I <sub>OUT</sub> (4)	S1 to S20	300	μA
	I <sub>OUT</sub> (5)	COM1 to COM4	3	mA
Allowable power dissipation	Pdmax	$Ta = -20 \text{ to } +70^{\circ}\text{C}$	200	mW
Operating temperature	Topr		-20 to +70	°C
Storage temperature	Tstg		-45 to +125	°C

## Allowable Operating Ranges at $Ta = -20~to~+70^{\circ}C,~V_{DD} = 0.9~to~1.8~V$

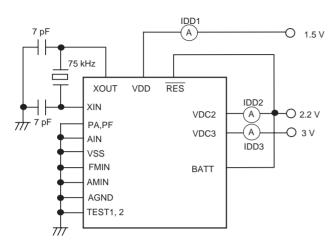
Parameter	Symbol	Conditions		Ratings		Linit
Farameter	Symbol	Conditions	min	typ	max	Unit
	V <sub>DD</sub> (1)	The voltage applied to the VDD pin	0.9	1.5	1.8	V
	V <sub>DD</sub> (2)	The voltage applied to the VDC1 pin	0.9	1.5	1.8	V
Supply voltage	V <sub>DD</sub> (3)	The voltage applied to the VDC2 pin	1.8	2.1	2.4	V
	V <sub>DD</sub> (4)	The voltage applied to the VDC3 pin	2.6	3.0	3.4	V
	V <sub>DD</sub> (5)	Memory retention voltage	0.9			V
	V <sub>IH</sub> (1)	Ports PC, PD, PG, and PH	0.7 V <sub>DD</sub> (1)		V <sub>DD</sub> (1)	V
Input high-level voltage	V <sub>IH</sub> (2)	Port PA	0.8 V <sub>DD</sub> (1)		V <sub>DD</sub> (1)	V
Input nign-level voltage	V <sub>IH</sub> (3)	Port PF	0.8 V <sub>DD</sub> (1)		V <sub>DD</sub> (3)	V
	V <sub>IH</sub> (4)	Ports BRES and BATT	0.6 V <sub>DD</sub> (1)		V <sub>DD</sub> (3)	V
	V <sub>IL</sub> (1)	Ports PC, PD, PG, and PH	0		0.3 V <sub>DD</sub> (1)	V
Input low-level voltage	V <sub>IL</sub> (2)	Port PA	0		0.2 V <sub>DD</sub> (1)	V
Input low-level voltage	V <sub>IL</sub> (3)	Port PF	0		0.2 V <sub>DD</sub> (1)	V
	V <sub>IL</sub> (4)	Ports BRES and BATT	0		0.2 V <sub>DD</sub> (1)	V
	V <sub>IN</sub> (1)	XIN	0.5		0.6	Vrms
Input amplitude	V <sub>IN</sub> (2)	FMIN, AMIN: V <sub>DD</sub> (3) = 2.1 V	0.035		0.35	Vrms
	V <sub>IN</sub> (3)	FMIN: V <sub>DD</sub> (3) = 2.1 V	0.05		0.35	Vrms
Input voltage range	V <sub>IN</sub> (4)	ADI0, ADI1, and V <sub>DD</sub>	0		V <sub>DD</sub> (4)	V
	F <sub>IN</sub> (1)	XIN: $CI \le 35 \text{ k}Ω$	70	75	80	kHz
Input frequency	F <sub>IN</sub> (2)	FMIN: $V_{IN}(2)$ , $V_{DD}(3) = 2.1 \text{ V}$	10		130	MHz
input nequency	F <sub>IN</sub> (3)	FMIN: $V_{IN}(3)$ , $V_{DD}(3) = 2.1 \text{ V}$	130		230	MHz
	F <sub>IN</sub> (4)	$AMIN(L): V_{IN}(2), V_{DD}(3) = 2.1 V$	0.5		10	MHz

## **Electrical Characteristics under allowable operating conditions**

Parameter	Symbol	Conditions		Ratings		Unit
- aramotor	Cymbol	Conditions	min	typ	max	U
	I <sub>IH</sub> (1)	$XIN: V_{DD}(1) = 1.8 \text{ V}, V_{DD}(2) = 1.8 \text{ V}, V_{DD}(3) = 2.1 \text{ V}$			3	μA
	I <sub>IH</sub> (2)	FMIN, and AMIN: $V_{DD}(3) = 2.1 \text{ V}$	3	8	20	μA
Input high-level voltage	I <sub>IH</sub> (3)	Ports BRES, BATT, and PF: V <sub>DD</sub> (3) = 2.1 V			4	μA
	I <sub>IH</sub> (4)	Ports PA (no pull-down resistor), PC, PD, PG, and PH: V <sub>DD</sub> (1) = 1.8 V			3	μΑ
	I <sub>IL</sub> (1)	$XIN: V_{DD}(1) = V_{DD}(2) = V_{DD}(3) = V_{SS}$			-3	μA
	I <sub>IL</sub> (2)	FMIN, and AMIN: V <sub>DD</sub> (3) = V <sub>SS</sub>	-3	-8	-20	μA
Input low-level voltage	I <sub>IL</sub> (3)	Ports BRES, BATT, and PF: $V_{DD}(3) = V_{SS}$			-4	μA
	I <sub>IL</sub> (4)	Ports PA (no pull-down resistor), PC, PD, PG, and PH: V <sub>DD</sub> (1) = V <sub>SS</sub>			-3	μA
Input floating voltage	V <sub>IF</sub>	Port PA pull-down resistor present			0.05 V <sub>DD</sub> (1)	V
B.II.I.	R <sub>PD</sub> (1)	Port PA pull-down resistor: V <sub>DD</sub> (1) = 1.3 V	75	100	200	kΩ
Pull-down resistor	R <sub>PD</sub> (2)	TEST1 and TEST2 pull-down resistors		10		kΩ
Hysteresis	V <sub>H</sub>	BRES	0.1 V <sub>DD</sub> (3)	0.2 V <sub>DD</sub> (3)		V
	V <sub>OH</sub> (1)	PB: I <sub>O</sub> = 1 mA	V <sub>DD</sub> (1) – 0.7 V <sub>DD</sub> (1)		V <sub>DD</sub> (1) – 0.3 V <sub>DD</sub> (1)	V
	V <sub>OH</sub> (2)	PC, PD, PG, PH: I <sub>O</sub> = 1 mA	V <sub>DD</sub> (1) – 0.3 V <sub>DD</sub> (1)			V
Output high-level voltage	V <sub>OH</sub> (3)	EO: I <sub>O</sub> = -500 μA	V <sub>DD</sub> (3) – 0.3 V <sub>DD</sub> (3)			V
	V <sub>OH</sub> (4)	XOUT I <sub>O</sub> = 1 μA	V <sub>DD</sub> (3) – 0.3 V <sub>DD</sub> (3)			V
	V <sub>OH</sub> (5)	S1 to S20: I <sub>O</sub> = 20 μA	V <sub>DD</sub> (4) – 1			V
	V <sub>OH</sub> (6)	COM1, CM2, COM3, and COM4: $I_O = 100 \mu A$	V <sub>DD</sub> (4) – 1			V
	V <sub>OH</sub> (7)	VREF: I <sub>O</sub> = 1 mA	V <sub>DD</sub> (3) – 1			V
	V <sub>OL</sub> (1)	PB: I <sub>O</sub> = -50 μA	0.3 V <sub>DD</sub> (1)		0.7 V <sub>DD</sub> (1)	V
	V <sub>OL</sub> (2)	PC, PD, PG, and PH: I <sub>O</sub> = -1 mA			0.3 V <sub>DD</sub> (1)	V
	V <sub>OL</sub> (3)	EO: I <sub>O</sub> = -500 μA			0.3 V <sub>DD</sub> (3)	V
0 / 1 / 1 /	V <sub>OL</sub> (4)	XOUT: I <sub>O</sub> = -1 μA			0.3 V <sub>DD</sub> (3)	V
output low-level voltage	V <sub>OL</sub> (5)	S1 to S20: I <sub>O</sub> = -20 μA			V <sub>DD</sub> (4)–2	٧
	V <sub>OL</sub> (6)	COM1, COM2, COM3, and COM4: $I_O = -100 \mu A$			V <sub>DD</sub> (4)–2	V
	V <sub>OL</sub> (7)	PE: I <sub>O</sub> = 2 mA			0.6 V <sub>DD</sub> (1)	V
	V <sub>OL</sub> (8)	AOUT: I <sub>O</sub> = 1 mA, AIN = 1.3 V: V <sub>DD</sub> (4) = 3 V			0.5	V
	I <sub>OFF</sub> (1)	PB, PC, PD, PG, PH, and E0 ports	-3		3	μA
Output off leakage current	I <sub>OFF</sub> (2)	AOUT and PE ports	-100		100	nA
A/D converter error		ADI0 and ADI1, V <sub>DD</sub>	-1/2		+1/2	LSB
	fosc(1)	FM, and PLLSTOP: V <sub>DD</sub> (3) = 2.1 V, Vcon = OPEN	300	600	900	kHz
Internal clock frequency	fosc(2)	AM	450		1200	kHz
	I <sub>DD1</sub> (1)	$V_{DD}(1) = 1.5 \text{ V}, V_{DD}(3) = 2.1 \text{ V}, V_{DD}(4) = 3.0 \text{ V}:$ $F_{IN}(2) 130 \text{ MHz}, Ta = 25^{\circ}\text{C}$		1		mA
	I <sub>DD2</sub> (2)	$V_{DD}(1) = 1.5 \text{ V}, V_{DD}(3) = 2.1 \text{ V}, V_{DD}(4) = 3.0 \text{ V}:$ $F_{IN}(2) 130 \text{ MHz}, Ta = 25^{\circ}\text{C}$		5		mA
	I <sub>DD3</sub> (3)	$V_{DD}(1) = 1.5 \text{ V}, V_{DD}(3) = 2.1 \text{ V}, V_{DD}(4) = 3.0 \text{ V}:$ $F_{IN}(2) 130 \text{ MHz}, Ta = 25^{\circ}\text{C}$		1		mA
	I <sub>DD1</sub> (4)	$V_{DD}(1) = 1.5 \text{ V}, V_{DD}(3) = 2.1 \text{ V}, V_{DD}(4) = 3.0 \text{ V}:$ Halt mode, Ta = 25°C *1		0.1		mA
Current drain	I <sub>DD2</sub> (5)	$V_{DD}(1) = 1.5 \text{ V}, V_{DD}(3) = 2.1 \text{ V}, V_{DD}(4) = 3.0 \text{ V}:$ Halt mode, Ta = 25°C *1		0.3		mA
	I <sub>DD3</sub> (6)	$V_{DD}(1) = 1.5 \text{ V}, V_{DD}(3) = 2.1 \text{ V}, V_{DD}(4) = 3.0 \text{ V}:$ Halt mode, Ta = 25°C *1		0.1		mA
	I <sub>DD1</sub> (7)	$V_{DD}(1) = 1.5 \text{ V}, V_{DD}(3) = 2.1 \text{ V}, V_{DD}(4) = 3.0 \text{ V}:$ With the oscillator stopped, Ta = 25°C *		100		nA
	I <sub>DD2</sub> (8)	$V_{DD}(1) = 1.5 \text{ V}, V_{DD}(3) = 2.1 \text{ V}, V_{DD}(4) = 3.0 \text{ V}$ : With the oscillator stopped, Ta = 25°C *		500		nA
	I <sub>DD3</sub> (9)	$V_{DD}(1) = 1.5 \text{ V}, V_{DD}(3) = 2.1 \text{ V}, V_{DD}(4) = 3.0 \text{ V}:$ With the oscillator stopped, Ta = 25°C *		100		nA

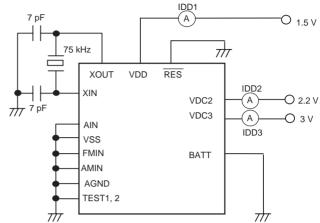
The halt mode current drain is due to 20 instructions being executed every 125 ms.

#### \*1 Halt mode current drain test conditions



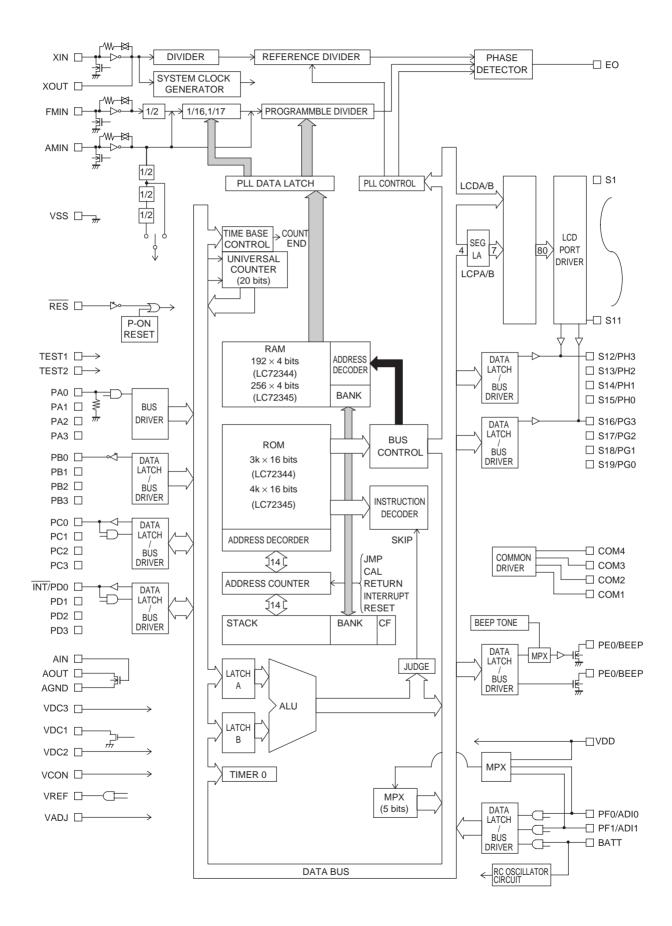
Leave all ports other than those mentioned above open. Select output mode for PC and PD. Select the segment function for S12 to S19.

#### \*2 Backup mode current drain test conditions



Leave all ports other than those mentioned above open. Select output mode for PC and PD. Select the segment function for S12 to S19.

#### **Block Diagram**



### **Pin Functions**

Pin No.	Pin	I/O	Function	I/O circuit
64 1	XIN XOUT	I 0	75 kHz crystal oscillator connections	
63	TEST1	I	IC testing.	
2	TEST2	I	These pins must be connected to ground.	_
6 5 4 3	PA0 PA1 PA2 PA3	ı	Special-purpose ports for key return signal input designed with a low threshold voltage. When a key matrix is formed in combination with port PB, simultaneous multiple key presses with up to 3 keys can be detected. The pull-down resistors are set up for all four pins at the same time with the IOS instruction (PWn = 2.b1). This setting cannot be specified for individual pins. In backup mode, these pins go to the input disabled state, and the pull-down resistors are disabled after a reset.	Input with built-in pull-down resistor
10 9 8 7	PB0 PB1 PB2 PB3	0	Unbalanced CMOS outputs. These outputs are switched with the IOS 0 instruction. Since these outputs are unbalanced, no diodes are required to prevent short circuits due to simultaneous multiple key presses. These outputs go to the high-impedance output state in backup mode. After a reset, they go to the high-impedance output state and remain in that state until an output instruction (OUT, SPB, or RPB) is executed.	Unbalanced CMOS push-pull output
14	PC0			CMOS push-pull output
13	PC1			
12	PC2		General-purpose I/O ports.	
11 18 17 16 15	PC3  INT/PD0  PD1  PD2  PD3  (*)	I/O	PD0 can be used as an external interrupt port. The IOS instruction (Pwn = 4, 5) is used for switching the general-purpose I/O port function, and these ports can be set to input or output in 1-bit units. (0: input, 1: output)  In backup mode they go to the input disabled high-impedance state.  After a reset, they switch to the general-purpose input port function.	
20 19	BEEP/PE0 PE1		General-purpose output and beep tone output shared function ports (PE0 only). The BEEP instruction is used to switch PE0 between the general-purpose output port and beep tone output functions. To use PE0 as a general-purpose output port, execute a BEEP instruction with b2 set to 0. Set b2 to 1 to use PE0 as the beep tone output port. The b0 and b1 bits are used to select the beep tone frequency. There are two beep tone frequencies supported.  *: When PE0 is set up as the beep tone output, executing an output instruction to PN0 only changes the state of the internal output latch, it does not affect the beep tone output in any way. Only the PE0 pin can be switched between the general-purpose output function and the beep tone output function; the PE1 pin only functions as a general-purpose output. These pins go to the high-impedance state in backup mode and remain in that state until an output instruction or a BEEP instruction is executed. Since these ports are open-drain ports, resistors must be inserted between these pins and V <sub>DD</sub> . These ports are set to their general-purpose output port function after a reset.	N-channel open-drain output

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Pin No.	Pin	I/O	Function	I/O circuit
			General-purpose input and A/D converter input shared function ports.  The IOS instruction (Pwn = FH) is used to switch between the general-purpose input and A/D	
23 22	PF0/ADI0 PF1/ADI1	I	converter port functions. The general-purpose input and A/D converter port functions can be switched in a bit units, with 0 specifying general-purpose input, and 1 specifying the A/D converter input function. To select the A/D converter function, set up the A/D converter pin with an IOS instruction with Pwn set to 1. The A/D converter is started with the UCC instruction (b3 = 1, b2 = 1). The ADCE flag is set when the conversion completes. The INR instruction is used to read in the data.	CMOS input/analog input
			*: If an input instruction is executed for one of these pins which is set up for analog input, the read in data will be at the low level since CMOS input is disabled. In backup mode these pins go to the input disabled high-impedance state. These ports are set to their general-purpose input port function after a reset. The A/D converter is a 5-bit successive approximation type converter, and features a conversion time of 1.28 ms. Note that the full-scale A/D converter voltage (1FH) is (63/96) times VDC3.	
			LCD driver segment output and general-purpose I/O shared function ports.	
			The IOS instruction* is used for switching both between the segment output and general-purpose I/O functions and between input and output for the general-purpose I/O port function.	
			When used as segment output ports	CMOS push-pull output
31	PG3/S19		The general-purpose I/O port function is selected with the IOS instruction (Pwn = 8).	
32	PG2/S18		b0 = S16 to 19/PG0 to 3 (0: Segment output, 1: PG0 to 3)	
33	PG1/S17		The general-purpose I/O port function is selected with the IOS instruction (Pwn = 9).	
34	PG0/S16		b0 = S12 to 15/PH0 to 3 (0: Segment output, 1: PH0 to 3)	
			When used as general-purpose I/O ports	
35	PH3/S15	0	The IOS instruction (Pwn = 6,7) is used to select input or output. Note that the mode can	
36	PH2/S14		be set in a bit units.	
37	PH1/S13		b0 = PG0	
38	PH0/S12		b2 = PG2 $b2 = PG2 $ $1: Output $ $b2 = PH2 $ $1: Output $ $1: Output$	
	(*)		b3 = PG3 b3 = PH3	
	, ,		In backup mode, these pins go to the input disabled high-impedance state if set up as general-purpose outputs, and are fixed at the low level if set up as segment outputs. These ports are set up as segment outputs after a reset.	<del>///</del>
			Although the general-purpose port/LCD port setting is a mask option, the IOS instruction must be used as described above to set up the port function.	
				CMOS push-pull output
			LCD driver segment output pins.	Д Д
			A 1/4-duty 1/2-bias drive technique is used.	<u> </u>
39 to 49	S11 to S1	0	The frame frequency is 75 Hz.	
			In backup mode, these outputs are fixed at the low level.	<u> </u>
			After a reset, these outputs are fixed at the low level.	<i>m</i>
			LCD driver common output pins.	
50	COM4		A 1/4-duty 1/2-bias drive technique is used.	
51	COM3	0	The frame frequency is 75 Hz.	
52	COM2	_	In backup mode, these outputs are fixed at the low level.	
53	COM1		After a reset, these outputs are fixed at the low level.	[ ]
			System reset input.	
54	RES	I	In CPU operating mode or halt mode, applications must apply a low level for at least one full machine cycle to reset the system and restart execution with the PC set to location 0. This pin is connected in parallel with the internal power on reset circuit.	
21	BATT	I	Battery presence/absence discrimination. The internal clock oscillator starts when a high level is input to this pin. The IN instruction can be used to determine whether or not a battery is present.	
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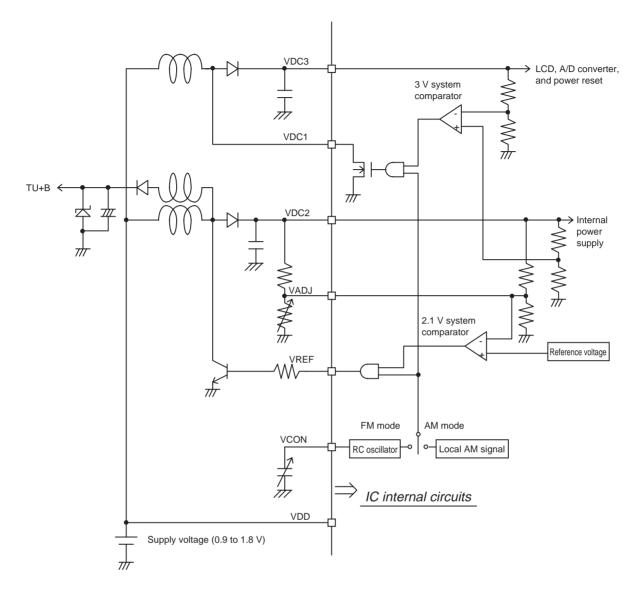
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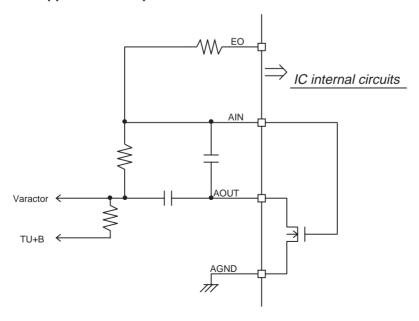
Pin No.	Pin	I/O	Function	I/O circuit
24	VDC1	ı	VDC3 (3 V) step-up control.	
27	VDC2	I	2.1 V power supply. Apply either the voltage stepped-up by the DC-DC converter or an equivalent voltage (2.1 V typical).	
25	VDC3	I	3 V power supply. Apply either the voltage stepped-up by VDC1 or an equivalent voltage (3 V typical).	
28	VREF	0	VDC2 step-up transistor drive.	
29	VCON	I	Frequency adjustment for the internal RC oscillator circuit. The RC oscillator frequency can be lowered by inserting a capacitor between this pin and ground.	
30	VADJ	0	The VDC3 voltage can be adjusted by inserting a resistor between this pin and ground.	
56	FMIN	I	FM VCO (local oscillator) input.  This pin is selected with the PLL instruction CW1.  The input must be capacitor coupled.  Input is disabled in backup mode, in halt mode, after a reset, and in PLL stop mode.	CMOS amplifier input
57	AMIN	I	AM VCO (local oscillator) input.  This pin and the bandwidth are selected with the PLL instruction CW1.  CW1 b1, b0  Bandwidth  11  0.5 to 10 MHz (MW, LW)  The input must be capacitor coupled.  Input is disabled in backup mode, in halt mode, after a reset, and in PLL stop mode.	CMOS amplifier input
59	EO	0	Main charge pump output. When the local oscillator frequency divided by N is higher than the reference frequency a high level is output, when lower, a low level is output, and the pin is set to the high-impedance state when the frequencies match.  This output goes to the high-impedance state in backup mode, in halt mode, after a reset, and in PLL stop mode.	CMOS push-pull output
60 61 62	AIN AOUT AGND	0	Transistor used for the low-pass filter amplifier.  Connect AGND to ground.	
26 58 55	VSS VSS VDD	_	Power supply pin. This pin must be connected to ground. This pin must be connected to ground. This pin must be connected to VDD. Supports A/D converter.	_

Note: \*Applications must establish the output data in advance with an OUT, SPB, or RPB instruction and then set the pin to output mode with an IOS instruction when using the I/O switchable ports as output pins.

## **DC-DC Converter Application Sample**



## **Low-Pass Filter Application Sample**



### LC72344W and LC72345W Instruction Set

#### Terminology

ADDR : Program memory address

b : Borrow C : Carry

DH : Data memory address High (Row address) [2 bits]
DL : Data memory address Low (Column address) [4 bits]

I : Immediate data [4 bits]
M : Data memory address
N : Bit position [4 bits]
Rn : Resister number [4 bits]
Pn : Port number [4 bits]

PW : Port control word number [4 bits]

r : General register (One of the address from 00H to 0FH of BANKO)

( ), [ ] : Contents of register or memory M (DH, DL) : Data memory specified by DH, DL

ction	Mnemonic	Ope	rand	Function	Operational function						Ir	nstructio	on format		
Instruction group	Willemonic	1st	2nd	Function	Operational function	f	е	d	С	b	а	9 8	7 6 5 4	3 2 1	1 0
	AD	r	М	Add M to r	$r \leftarrow (r) + (M)$	0	1	0	0	0	0	DH	DL	r	
	ADS	r	М	Add M to r, then skip if carry	$r \leftarrow (r) + (M)$ , skip if carry	0	1	0	0	0	1	DH	DL	r	
suc	AC	r	М	Add M to r with carry	$r \leftarrow (r) + (M) + C$	0	1	0	0	1	0	DH	DL	r	
Addition instructions	ACS	r	М	Add M to r with carry, then skip if carry	$r \leftarrow (r) + (M) + C$ skip if carry	0	1	0	0	1	1	DH	DL	r	
l in	Al	М	- 1	Add I to M	$M \leftarrow (M) + I$	0	1	0	1	0	0	DH	DL	- 1	
ditic	AIS	М	1	Add I to M, then skip if carry	$M \leftarrow (M) + I$ , skip if carry	0	1	0	1	0	1	DH	DL	- 1	
Ad	AIC	М	- 1	Add I to M with carry	$M \leftarrow (M) + I + C$	0	1	0	1	1	0	DH	DL	- 1	
	AICS	М	ı	Add I to M with carry, then skip if carry	$M \leftarrow (M) + I + C$ , skip if carry	0	1	0	1	1	1	DH	DL	I	
	SU	r	М	Subtract M from r	$r \leftarrow (r) - (M)$	0	1	1	0	0	0	DH	DL	r	
S	SUS	r	М	Subtract M from r, then skip if borrow	$r \leftarrow (r) - (M),$ skip if borrow	0	1	1	0	0	1	DH	DL	r	
tion	SB	r	М	Subtract M from r with borrow	$r \leftarrow (r) - (M) - b$	0	1	1	0	1	0	DH	DL	r	
instructions	SBS	r	М	Subtract M from r with borrow, then skip if borrow	$r \leftarrow (r) - (M) - b$ , skip if borrow	0	1	1	0	1	1	DH	DL	r	
tion	SI	М	ı	Subtract I from M	$M \leftarrow (M) - I$	0	1	1	1	0	0	DH	DL	- 1	
Subtraction	SIS	М	ı	Subract I from M, then skip if borrow	$M \leftarrow (M) - I$ , skip if borrow	0	1	1	1	0	1	DH	DL	I	
0	SIB	М	1	Subtract I from M with borrow	$M \leftarrow (M) - I - b$	0	1	1	1	1	0	DH	DL	1	
	SIBS	М	I	Subtract I from M with borrow, then skip if borrow	$M \leftarrow (M) - I - b$ , skip if borrow	0	1	1	1	1	1	DH	DL	I	

Continued on next page.

Continued from preceding page.

nat	on format	structio	lr							Operational function	Function	rand	Ope	Mnemonic	ction
5 5 4 3 2 1 0	7 6 5 4	9 8	а	b	С	C	d	е	f	Operational function	Function	2nd	1st	winemonic	Instruction group
DL r	DL	DH	0	0	1	1	0	0	0	(r) – (M), skip if zero	Skip if r equal to M	М	r	SEQ	
DL I	DL	DH	0	1	1	1	0	0	0	(M) – I, skip if zero	Skip if M equal to I	I	М	SEQI	ctior
DL I	DL	DH	1	0	0	(	0	0	0	(M) - I, skip if not zero	Skip if M not equal to I	I	М	SNEI	struc
DL r	DL	DH	0	1	1	1	0	0	0	(r) – (M), skip if not borrow	Skip if r is greater than or equal to M	М	r	SGE	ison in
DL I	DL	DH	1	1	1	1	0	0	0	(M) – I, skip if not borrow	Skip if M is greater than equal to I	I	М	SGEI	Comparison instruction
DL I	DL	DH	1	1	0	(	0	0	0	(M) – I, skip if borrow	Skip if M is less than I	I	М	SLEI	
DL r	DL	DH	0	0	0	C	1	0	0	$r \leftarrow (r) \text{ AND (M)}$	AND M with r	М	r	AND	suc
DL I	DL	DH	1	0	0	C	1	0	0	$M \leftarrow (M) \text{ AND I}$	AND I with M	I	М	ANDI	uctic
DL r	DL	DH	0	1	0	C	1	0	0	$r \leftarrow (r) OR (M)$	OR M with r	М	r	OR	nstrı
DL I	DL	DH	1	1	0	C	1	0	0	$M \leftarrow (M) OR I$	OR I with M	I	М	ORI	ioni
DL r	DL	DH	0	0	1	1	1	0	0	$r \leftarrow (r) \text{ XOR (M)}$	Exclusive OR M with r	М	r	EXL	erat
DL I	DL	DH	0	1	1	1	1	0	0	$M \leftarrow (M) \text{ XOR I}$	Exclusive OR M with M	I	М	EXLI	la op
1 0 r	1 1 1 0	0 0	0	0	0	C	0	0	0	carry (r)	Shift r right with carry		r	SHR	Logical operation instructions
DL r	DL	DH	0	0	1	1	0	1	1	$r \leftarrow (M)$	Load M to r	М	r	LD	
DL r	DL	DH	1	0	1	1	0	1	1	M ← (r)	Store r to M	r	М	ST	suc
DL r	DL	DH	0	1	1	1	0	1	1	[DH, Rn] ← (M)	Move M to destination M referring to r in the same row	М	r	MVRD	structi
DL r	DL	DH	1	1	1	1	0	1	1	M ← [DH, Rn]	Move source M referring to r to M in the same row	r	М	MVRS	Transfer instructions
DL1 DL2	DL1	DH	0	0	0	C	1	1	1	$[DH, DL1] \leftarrow [DH, DL2]$	Move M to M in the same row	M2	M1	MVSR	Tra
DL I	DL	DH	1	0	0	C	1	1	1	$M \leftarrow I$	Move I to M	I	М	MVI	
DL N	DL	DH	0	0	1	1	1	1	1	if M (N) = all 1s, then skip	Test M bits, then skip if all bits specified are true	N	М	TMT	test
DL N	DL	DH	1	0	1	1	1	1	1	if M (N) = all 0s, then skip	Test M bits, then skip if all bits specified are false	N	М	TMF	Bit 1 instruc
13 bits)	DDR (13 bits)	ΑC					0	0	1	PC ← ADDR	Jump to the address	DR	AD	JMP	tine
13 bits)	DDR (13 bits)	ΑC					1	0	1	$ PC \leftarrow ADDR \\ Stack \leftarrow (PC) + 1 $	Call subroutine	DR	AD	CAL	subrou
0 0	1 0 0 0	0 0	0	0	0	(	0	0	0	PC ← Stack	Return from subroutine			RT	struc
0 0 1	1 0 0 1	0 0	0	0	0	C	0	0	0	PC ← Stack, BANK ← Stack, CARRY ← Stack	Return from interrupt			RTI	Sump s
	DDR (	DH DH AC	0 1 0 1	0 0 0	0 11 1 1 0 0	1	1 1 1 0 1 0	1 1 1 1 0 0	1 1 1 1 0	$[DH, DL1] \leftarrow [DH, DL2]$ $M \leftarrow I$ if M (N) = all 1s, then skip  if M (N) = all 0s, then skip $PC \leftarrow ADDR$ $PC \leftarrow ADDR$ $Stack \leftarrow (PC) + 1$ $PC \leftarrow Stack$ $PC \leftarrow Stack$ $PC \leftarrow Stack$ $PC \leftarrow Stack$ $PANK \leftarrow Stack$	Move M to M in the same row Move I to M Test M bits, then skip if all bits specified are true Test M bits, then skip if all bits specified are false Jump to the address Call subroutine Return from subroutine	M2 I N N DR	M1 M M	MVSR MVI TMT TMF JMP CAL RT	Jump and subroutine Bit test Transf instructions

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